

Search Notes



Application/Control No.

10/761,926

Examiner

Betsey M. Hoey

Applicant(s)/Patent under
Reexamination

ZAWADA ET AL.

Art Unit

1724

SEARCHED

Class	Subclass	Date	Examiner
210	(758)		
	(759)		
	764		
252	175		
	186.1		
422	28		
424	409	4/28/05	BMA

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
inventor name	4/7/05	BMA
STIC search	4/7/05	BMA